

# **IMAGE RECOGNITION BASED ON HIDDEN MARKOV EIGEN-IMAGE MODELS USING VARIATIONAL BAYESIAN METHOD**



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# OUTLINE

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- Background & introduction
- Models
  - ◆ Probabilistic eigen-image models (PEMs)
  - ◆ Separable lattice hidden Markov models (SL-HMMs)
  - ◆ Hidden Markov eigen-image models (HMEMs)
- Training criterion
  - ◆ Maximum likelihood (ML) criterion
  - ◆ Bayesian criterion
    - HEMEs using variational Bayesian (VB) method (proposed)
- Experiments
  - ◆ Face recognition experiments
  - ◆ Conclusion & future work

# BACKGROUND

- Image recognition
  - ◆ Assignment of a label to a given input image
    - Biometrics, OCR, video recognition, etc.
  - ◆ Increase in demand in various fields
    - Security, industrial inspection, entertainment, etc.
- Approach to geometric variation in image recognition
  - ◆ Heuristic normalization techniques
    - Development of task-dependent techniques require high cost
  - ◆ Local features (HOG, SIFT, etc.)
    - Global information can't use
  - ◆ Classifiers
    - Subspace method : corresponding to **only** pattern variation
    - Characteristic of geometric variation is not considered

Focus on techniques for modeling geometric variations explicitly

# INTRODUCTION

- Hidden Markov eigen-image models (HMEMs) [Nankaku, et al.; '06]
  - ◆ Probabilistic PCA and factor analysis
    - Linear feature extraction
  - ◆ Separable lattice HMMs [Kurata, et al.; '06]
    - Invariance size and location
  - ◆ Over-fitting problem because of complex model structures
- Training criterion of probabilistic models
  - ◆ Maximum likelihood (ML) criterion
    - ML criterion produces point estimation of model parameters  
⇒ Over-fitting problem when amount of data is insufficient
  - ◆ Bayesian criterion
    - Estimation of posterior distributions using prior information  
⇒ High generalization ability

Integrating  
two models

Apply Bayesian criterion to HMEMs

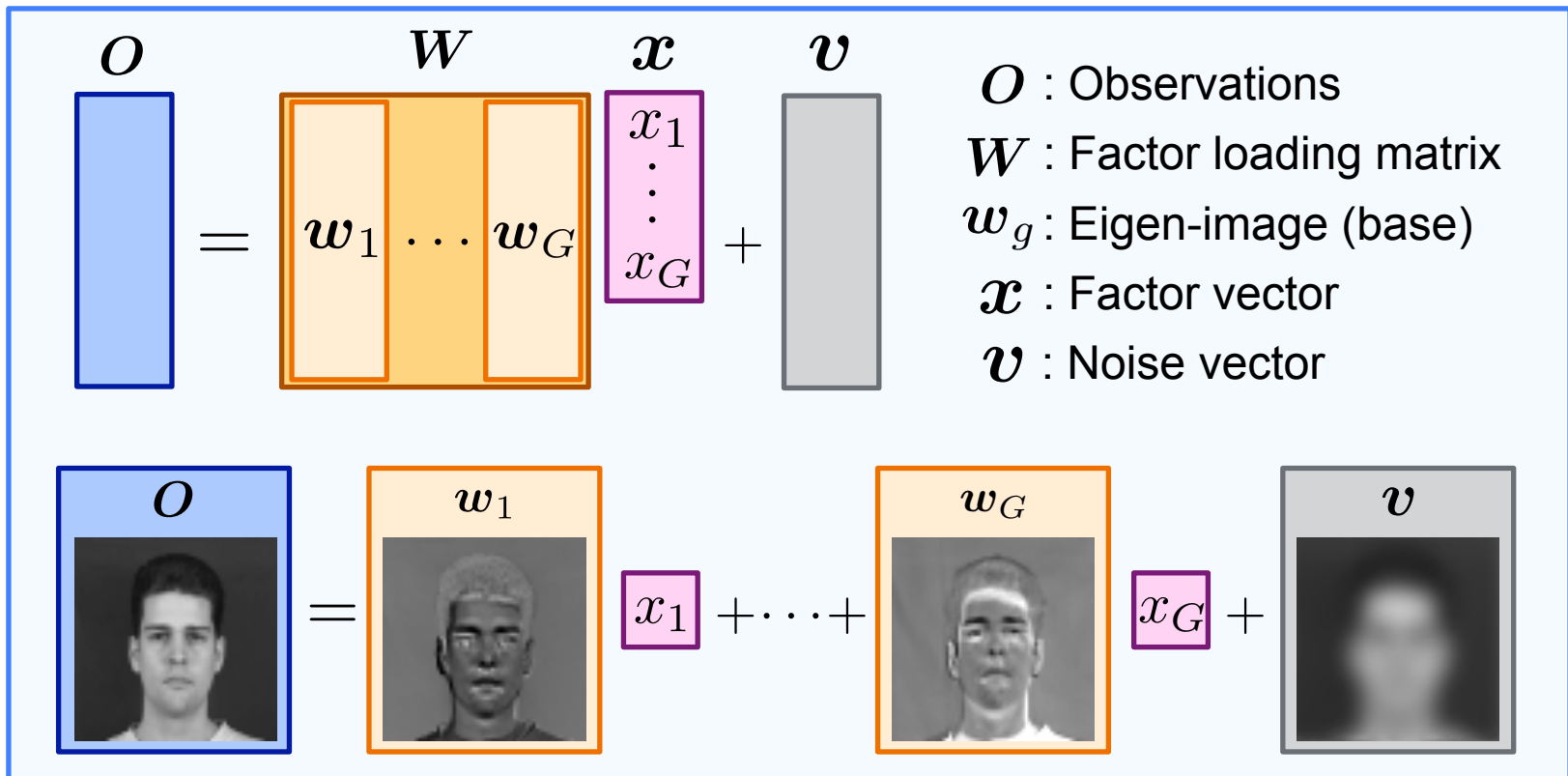
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# PROBABILISTIC EIGEN-IMAGE MODELS (PEMs)

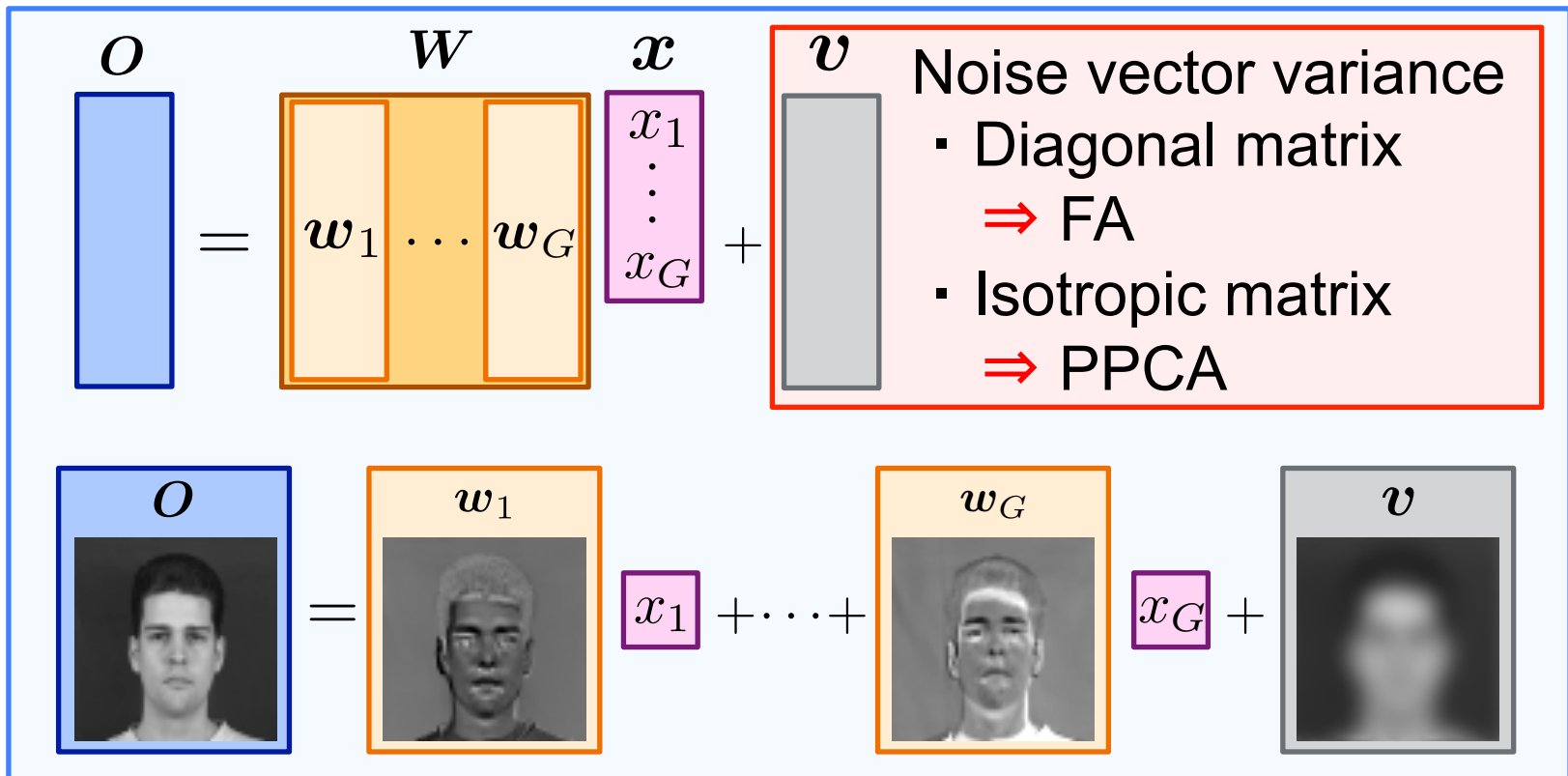
- Eigen-images are represented by probabilistic models
  - ◆ Probabilistic principal component analysis (PPCA)
  - ◆ Factor analysis (FA)



- ☺ Linear feature extraction based on statistical analysis
- ☹ Image normalization is required as pre-processing

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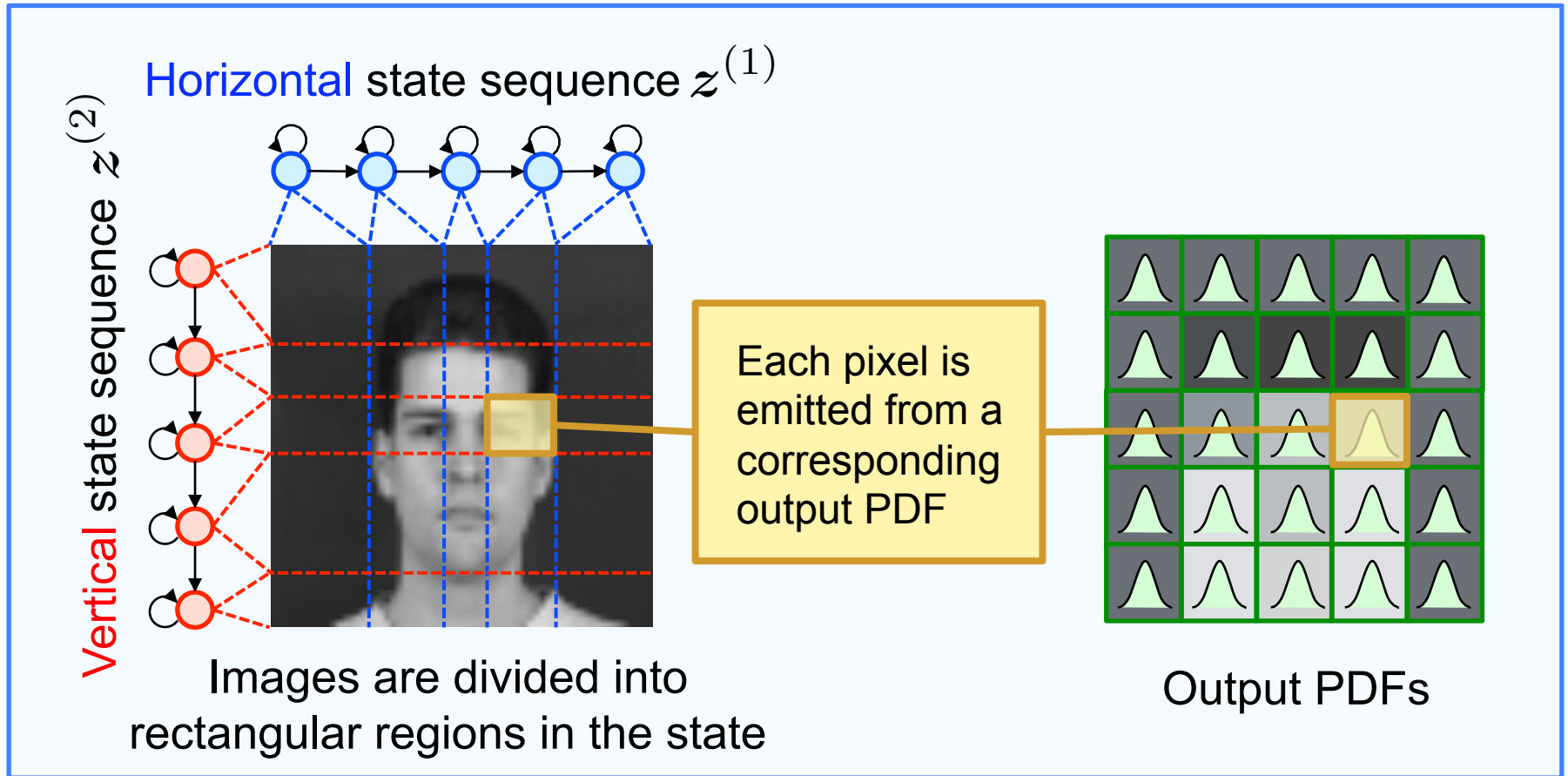


☺ Linear feature extraction based on statistical analysis

☹ Image normalization is required as pre-processing

# SEPARABLE LATTICE HMMs (SL-HMMs)

- SL-HMMs have horizontal and vertical Markov chains
  - State sequences of horizontal and vertical are independent



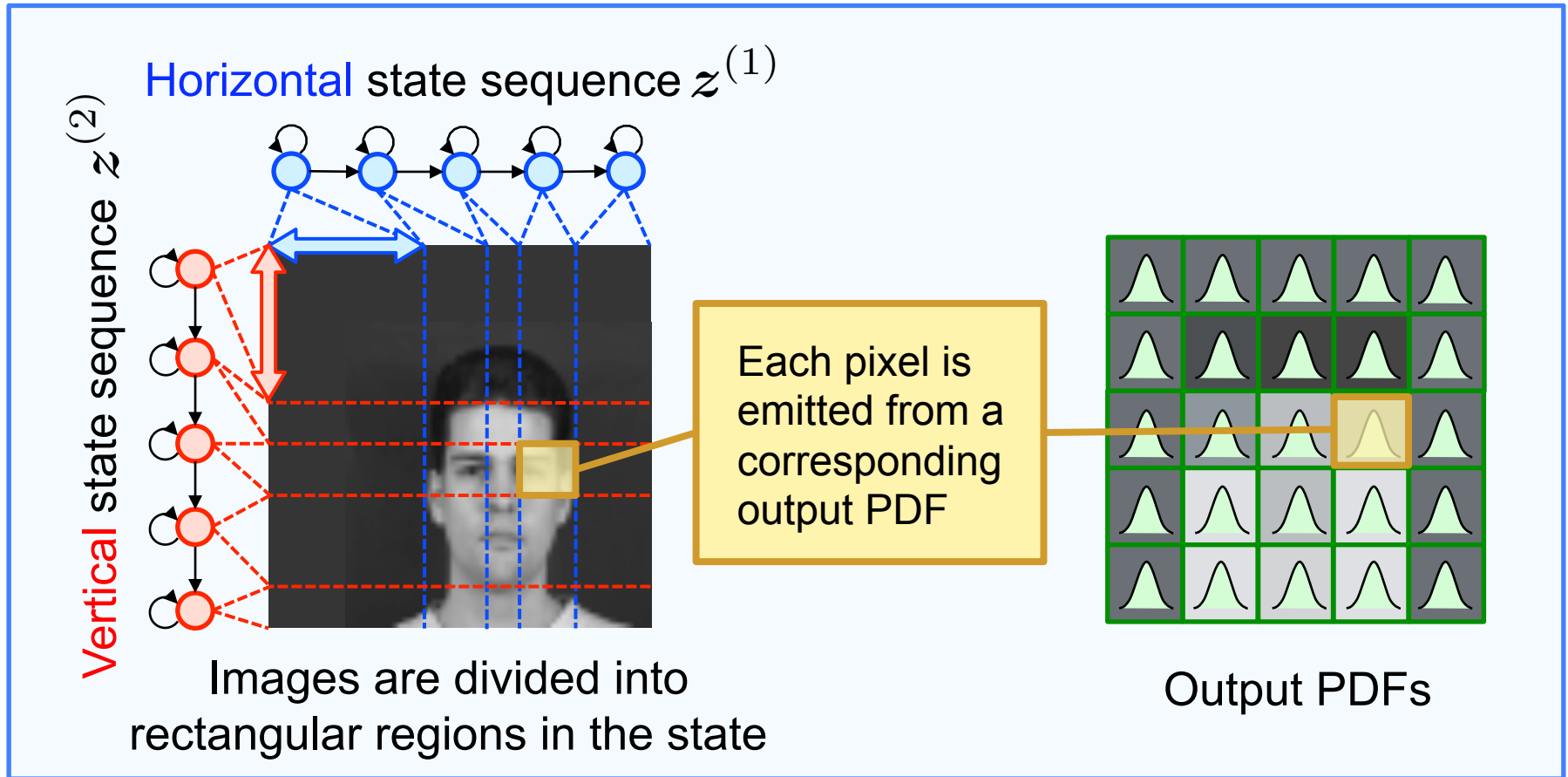
☺ Include size-and-location-normalization

☹ Independence assumption of observations



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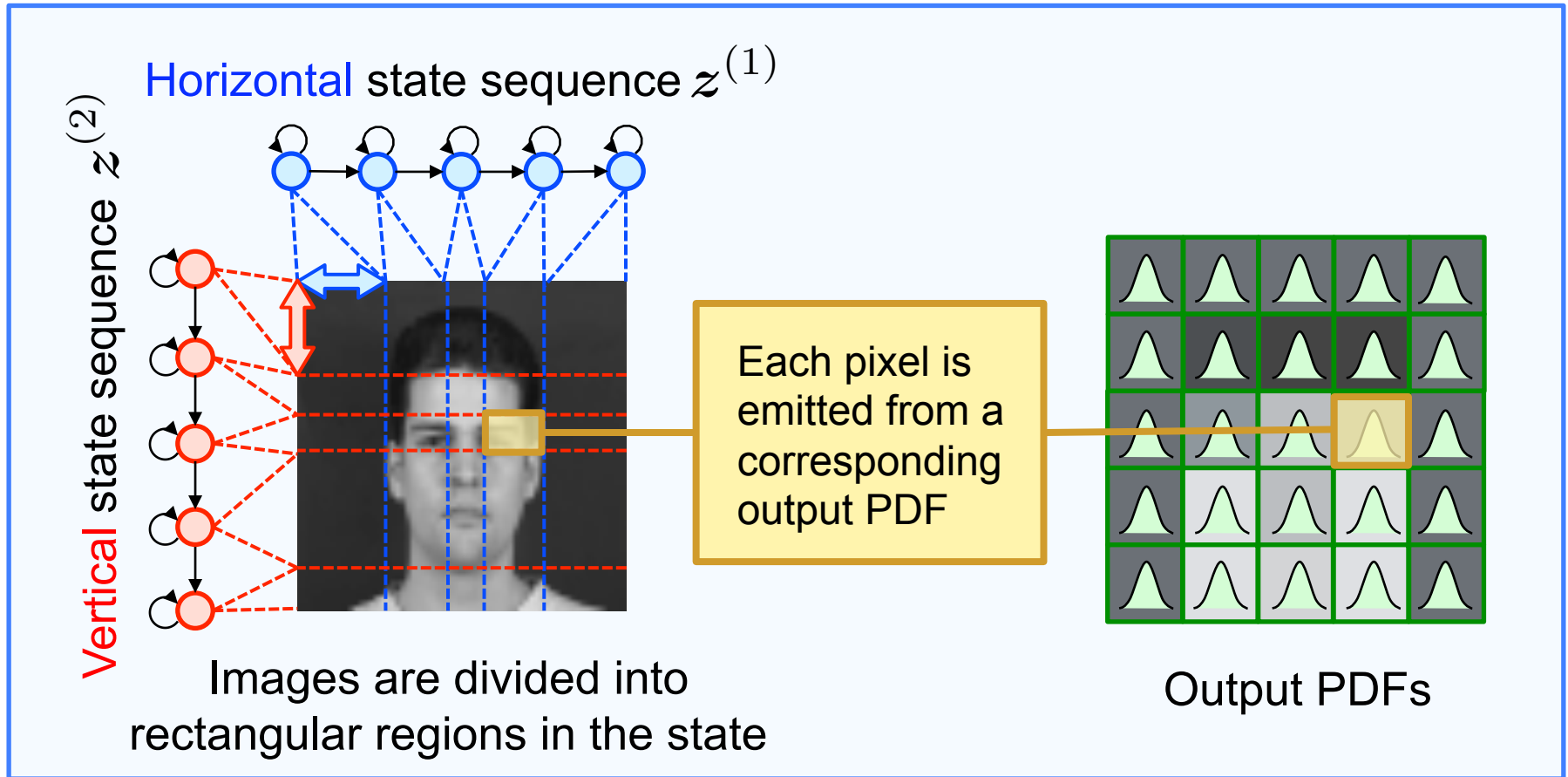


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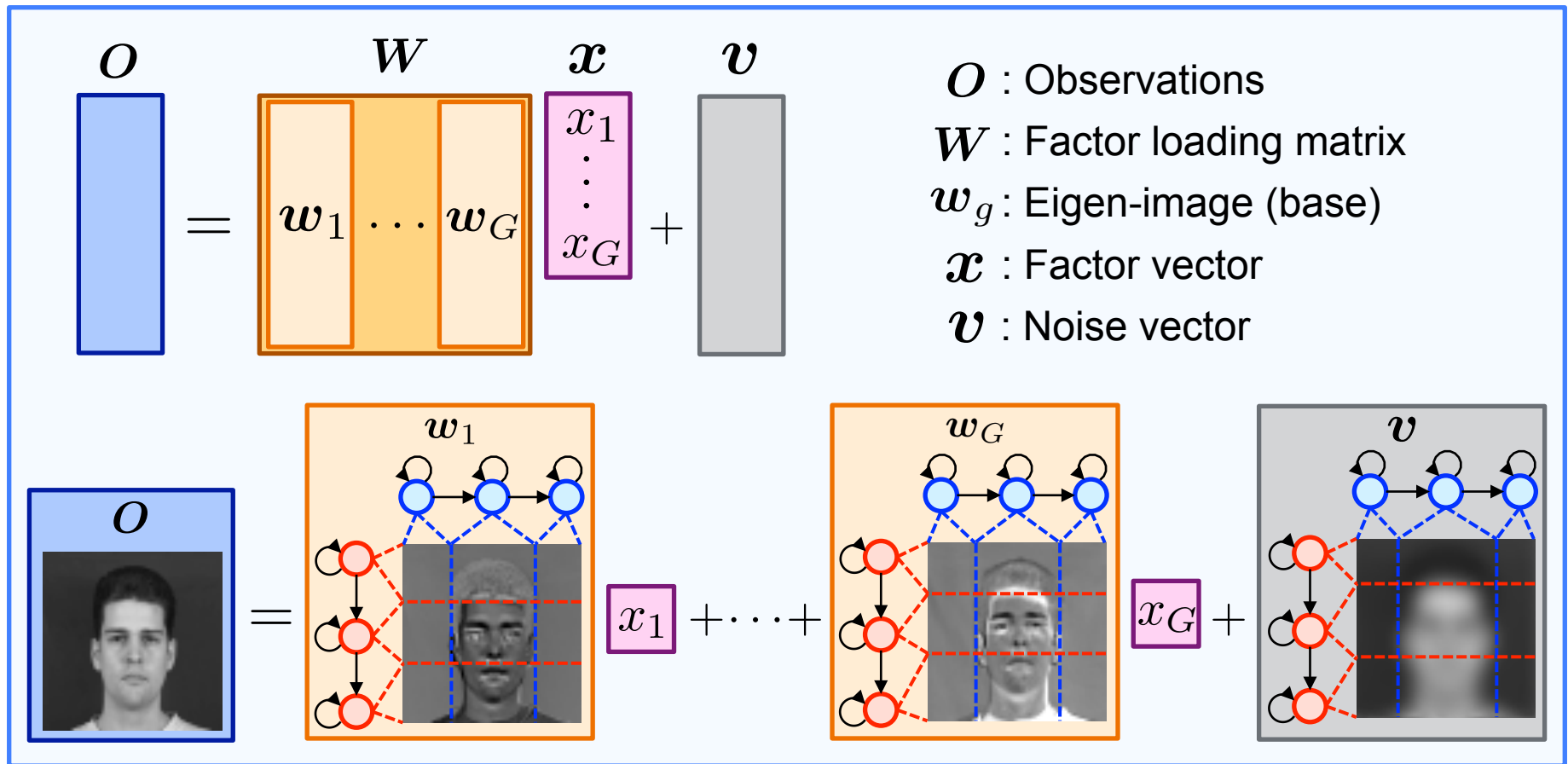


☺ Include size-and-location-normalization

☹ Independence assumption of observations

# HIDDEN MARKOV EIGEN-IMAGE MODELS (HMEMs)

- Integration of PEMs and SL-HMMs
- Eigen-images and noise are generated from SL-HMMs



☺ Linear feature extraction and include size-and-location-normalization

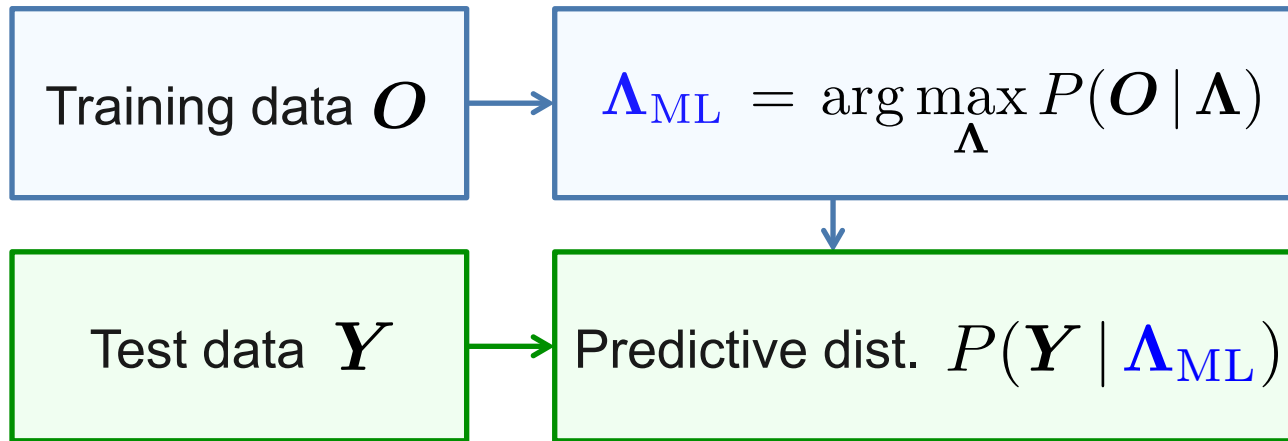
# OUTLINE




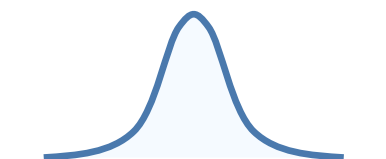
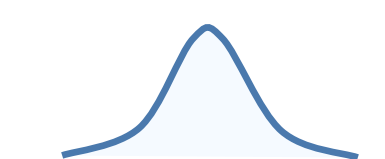
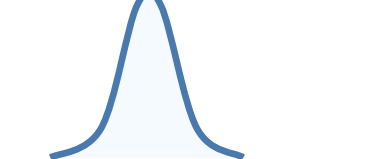
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# MAXIMUM LIKELIHOOD (ML) CRITERION

- Optimal model parameters  $\Lambda_{\text{ML}}$  are estimated by maximizing the likelihood

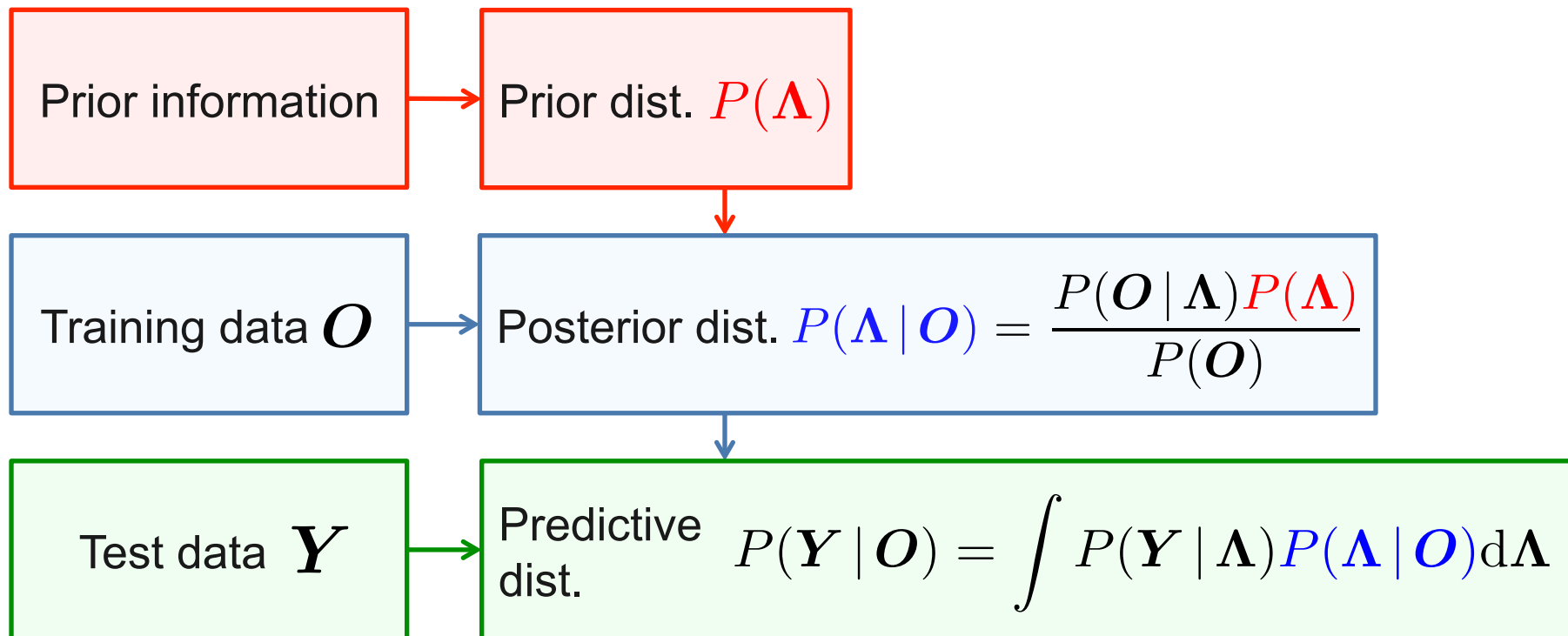


Amount of training data	Parent population	Large	Small
Training data			
Estimated distribution			

☹️ Estimation accuracy is decreased by over-fitting problem

# BAYESIAN CRITERION

- Estimation of posterior distribution



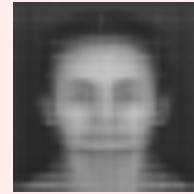
# BAYESIAN CRITERION

- Estimation of posterior distribution

Prior information

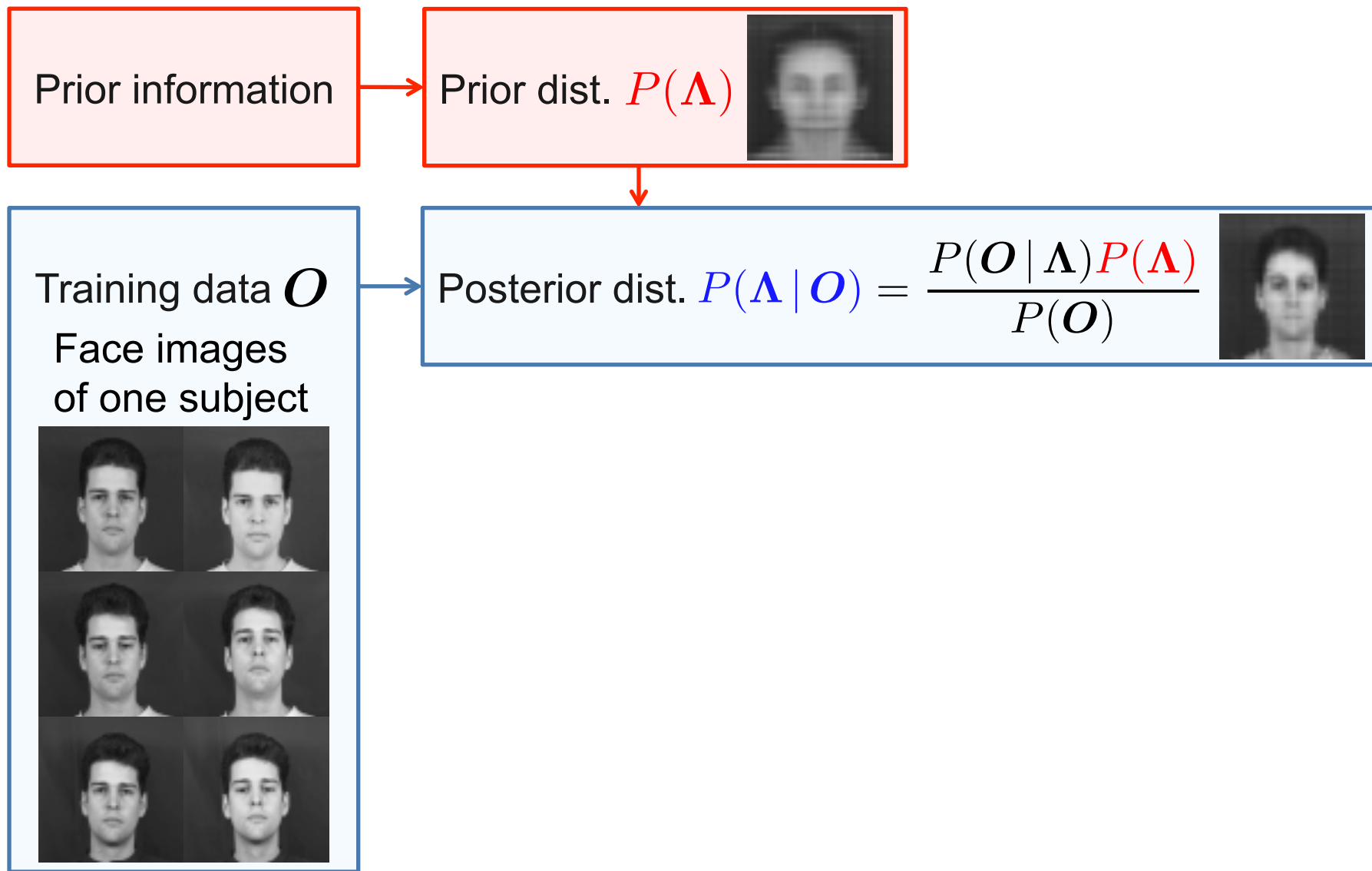
Large amount  
of face images

Prior dist.  $P(\Lambda)$



# BAYESIAN CRITERION

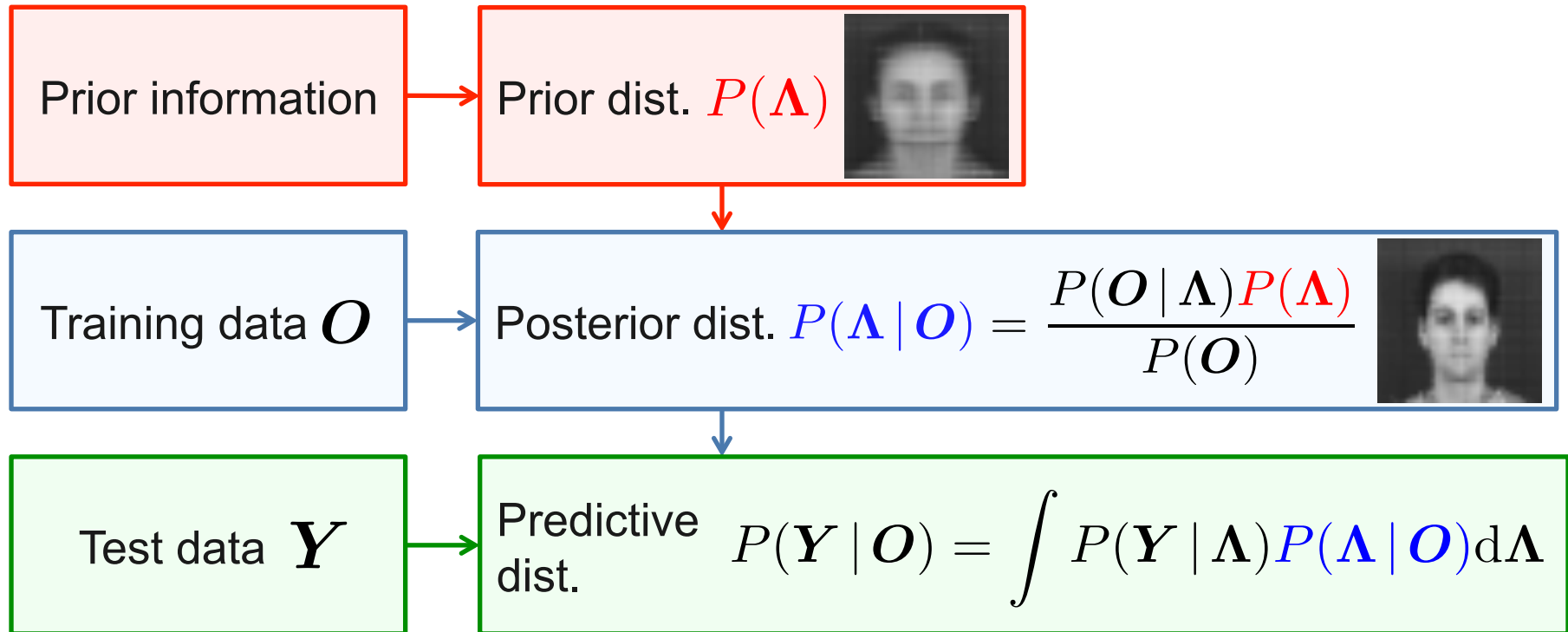
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# BAYESIAN CRITERION

- Estimation of posterior distribution

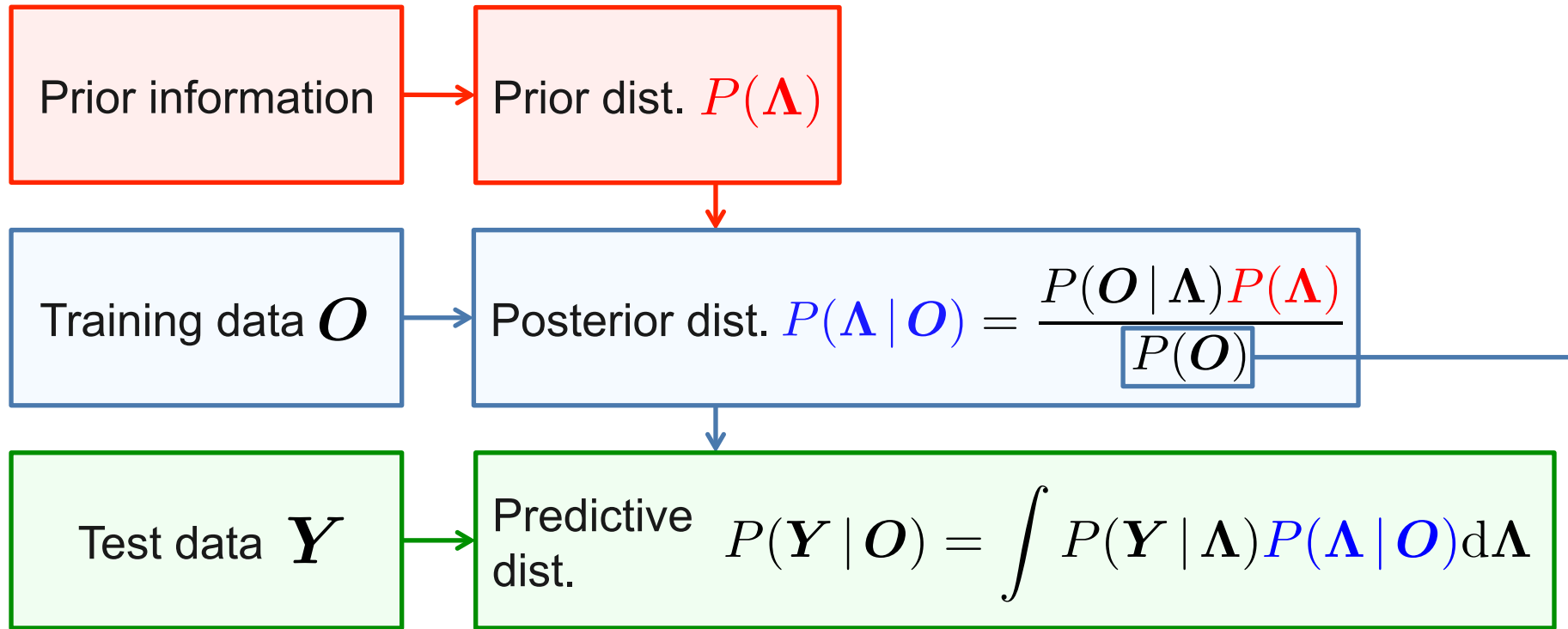


😊 Using prior dist. and marginalization of model parameters

😞 Complicated integral and expectation computations

# BAYESIAN CRITERION

- Estimation of posterior distribution



😊 Using prior dist. and marginalization of model parameters

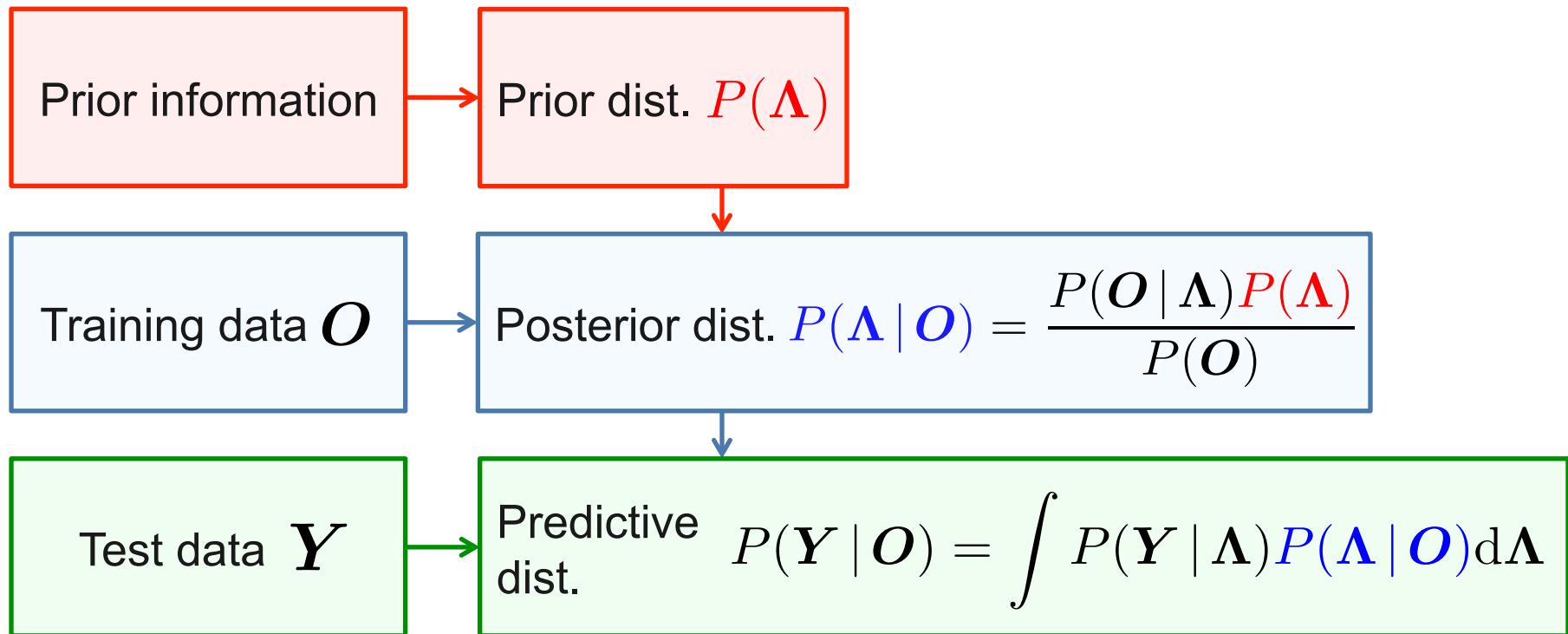
😞 Complicated integral and expectation computations

$$P(\mathbf{O}) = \sum_z \iint P(\mathbf{O}, \mathbf{x}, \mathbf{z} | \Lambda) P(\Lambda) d\mathbf{x} d\Lambda$$

$\mathbf{x}, \mathbf{z}$  : Hidden variable

# BAYESIAN CRITERION

## ◦ Estimation of posterior distribution



😊 Using prior dist. and marginalization of model parameters

😞 Complicated integral and expectation computations

- ⇒
- MCMC method [Gilks, et al.; '96]
  - MAP method [Gauvain, et al.; '94]
  - VB method [Attias; '99]

# VARIATIONAL BAYESIAN (VB) METHOD (1/2)

- Estimation of approximated posterior dist.
- Define a lower bound  $\mathcal{F}(Q)$  of log marginal likelihood

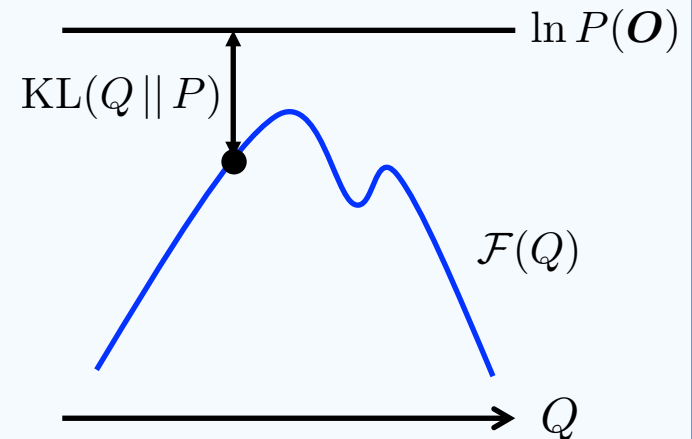
$$\ln P(\mathbf{O}) \geq \sum_{\mathbf{z}^{(1)}} \sum_{\mathbf{z}^{(2)}} \iint Q(\mathbf{x}, \mathbf{z}^{(1)}, \mathbf{z}^{(2)}, \mathbf{\Lambda}) \ln \frac{P(\mathbf{O}, \mathbf{z}^{(1)}, \mathbf{z}^{(2)}, \mathbf{\Lambda})}{Q(\mathbf{x}, \mathbf{z}^{(1)}, \mathbf{z}^{(2)}, \mathbf{\Lambda})} d\mathbf{x} d\mathbf{\Lambda}$$
$$= \mathcal{F}(Q)$$

$\mathbf{x}$  : Factor vector     $\mathbf{z}^{(1)}$  : Horizontal state sequence  
 $Q(\mathbf{x}, \mathbf{z}^{(1)}, \mathbf{z}^{(2)}, \mathbf{\Lambda})$  : Arbitrary dist.     $\mathbf{z}^{(2)}$  : Vertical state sequence

- KLD between arbitrary dist.  $Q$  and true posterior dist.  $P$

$$\text{KL}(Q \parallel P) = \ln P(\mathbf{O}) - \mathcal{F}(Q)$$

- Maximizing lower bound  $\mathcal{F}(Q)$   
 $\Leftrightarrow$  Minimizing KLD
- Arbitrary dist.  $Q$  represents approximated posterior dist.



# VARIATIONAL BAYESIAN (VB) METHOD (2/2)

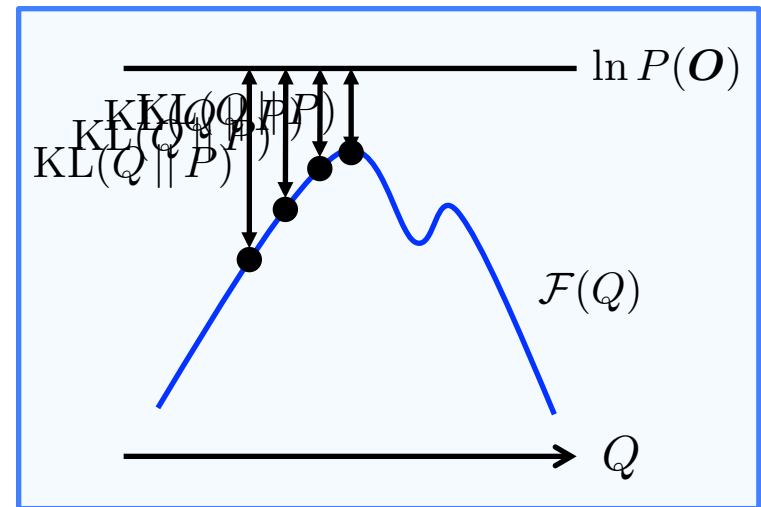
- Assume the independency of random variables

$$\begin{aligned} P(\mathbf{x}, \mathbf{z}^{(1)}, \mathbf{z}^{(2)}, \mathbf{\Lambda} \mid \mathbf{O}) &\approx Q(\mathbf{x}, \mathbf{z}^{(1)}, \mathbf{z}^{(2)}, \mathbf{\Lambda}) \\ &= Q(\mathbf{x})Q(\mathbf{z}^{(1)})Q(\mathbf{z}^{(2)})Q(\mathbf{\Lambda}) \end{aligned}$$

$Q(\mathbf{x}, \mathbf{z}^{(1)}, \mathbf{z}^{(2)}, \mathbf{\Lambda})$  : Arbitrary dist.     $Q(\cdot)$  : VB posterior dist.

- Updates of VB posterior dist. increase the value of lower bound  $\mathcal{F}(Q)$  at each iteration until convergence

VB E-step	$\begin{aligned} \bar{Q}(\mathbf{z}^{(1)}) &= \arg \max_{Q(\mathbf{z}^{(1)})} \mathcal{F} \\ \bar{Q}(\mathbf{z}^{(2)}) &= \arg \max_{Q(\mathbf{z}^{(2)})} \mathcal{F} \\ \bar{Q}(\mathbf{x}) &= \arg \max_{Q(\mathbf{x})} \mathcal{F} \end{aligned}$
VB M-step	$\bar{Q}(\mathbf{\Lambda}) = \arg \max_{Q(\mathbf{\Lambda})} \mathcal{F}$



Apply VB method to HMEMs

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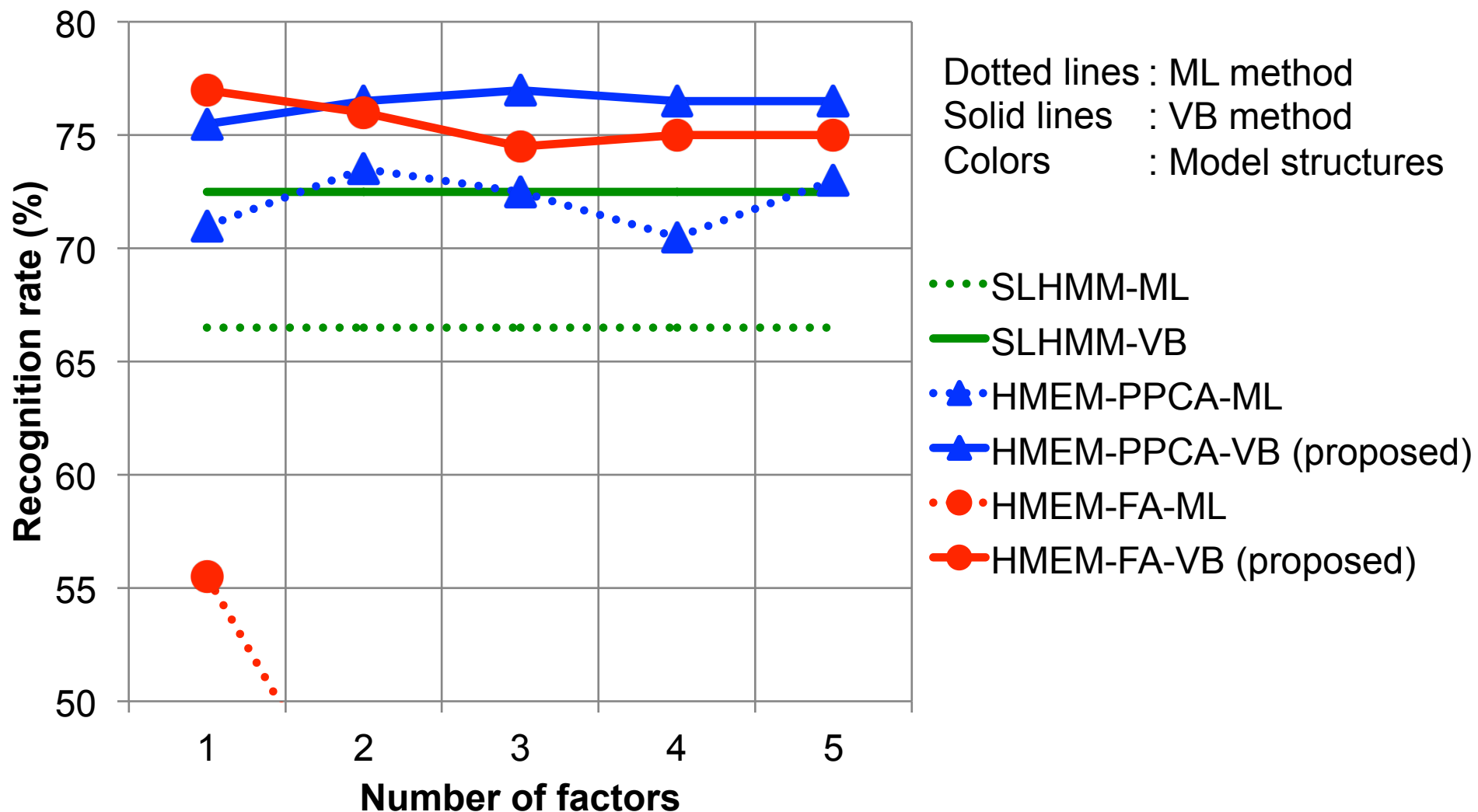
# FACE RECOGNITION EXPERIMENTS

- Experimental conditions

Database	XM2VTS
Image size	64 × 64 pixel, Gray-scale
Training data	6 images per subject × 100 subjects
Test data	2 images per subject × 100 subjects
Model structure	SL-HMM, HMEM-PPCA, HMEM-FA
Number of states	32 × 32 states
Estimate method	ML method (ML criterion), VB method (Baysian criterion)
Prior distribution	Uniform distribution (flat), Universal background model (UBM)

# RECOGNITION RATES (COMPARING ML AND VB)

Comparing ML and VB methods (prior dist. : uniform dist.)

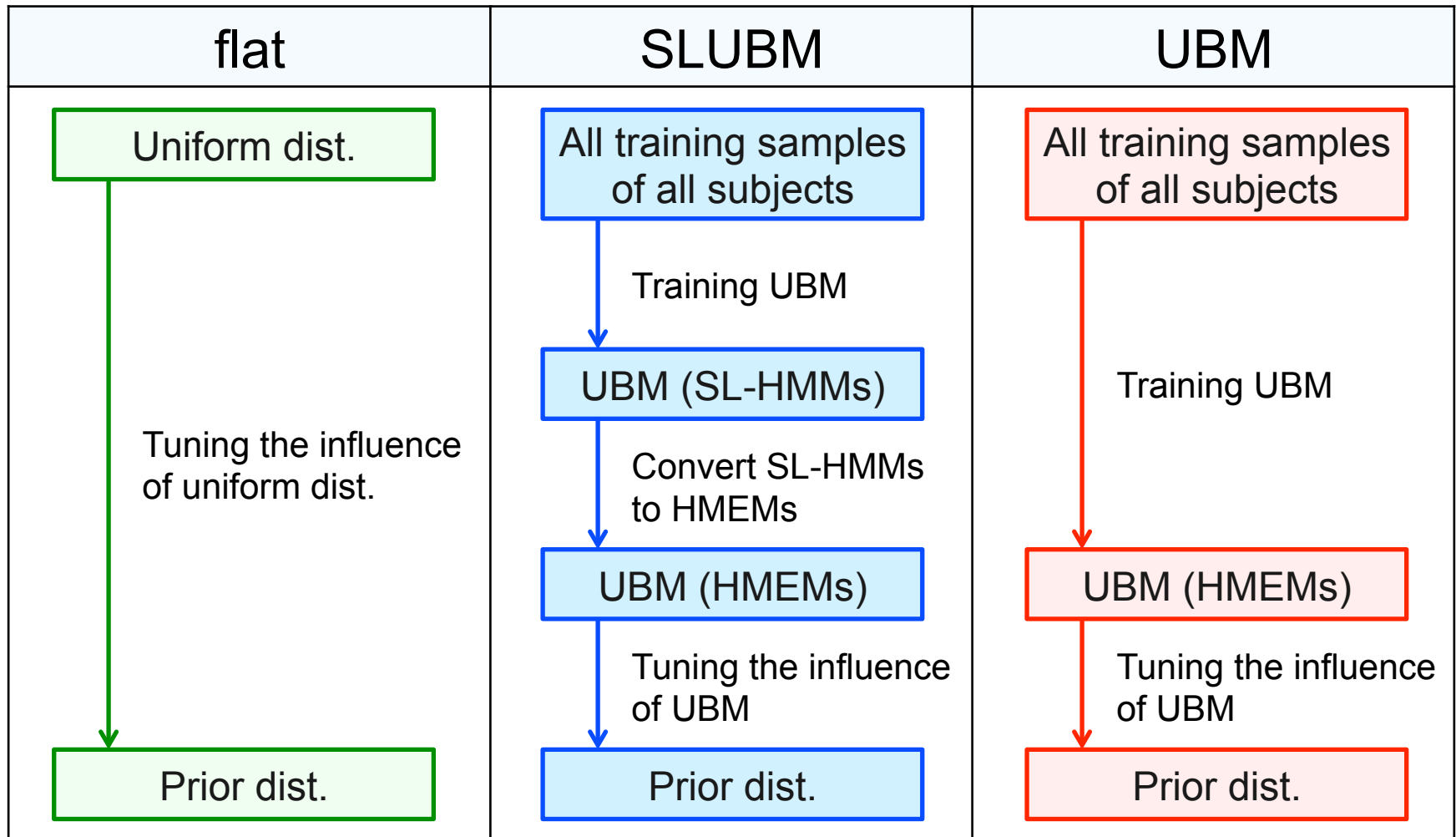


VB method achieved higher recognition rates than ML method



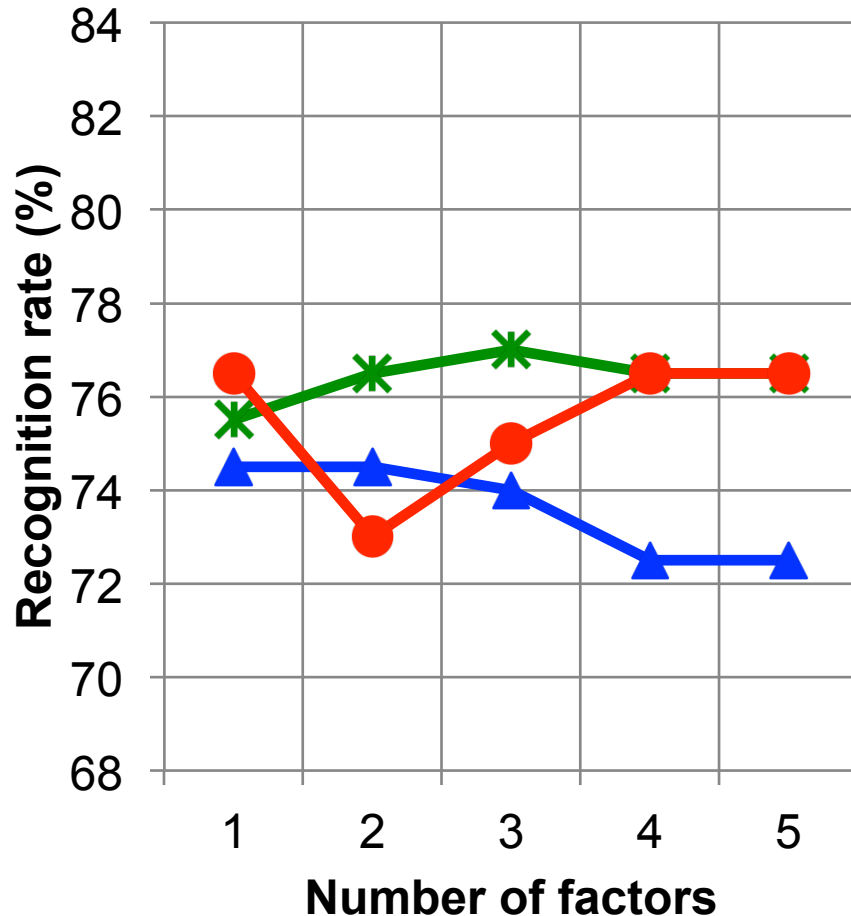
# PRIOR DISTRIBUTION

- Prior dist. affects the estimation of posterior dist.
  - ◆ Uniform distribution (flat)
  - ◆ Universal background model (UBM)

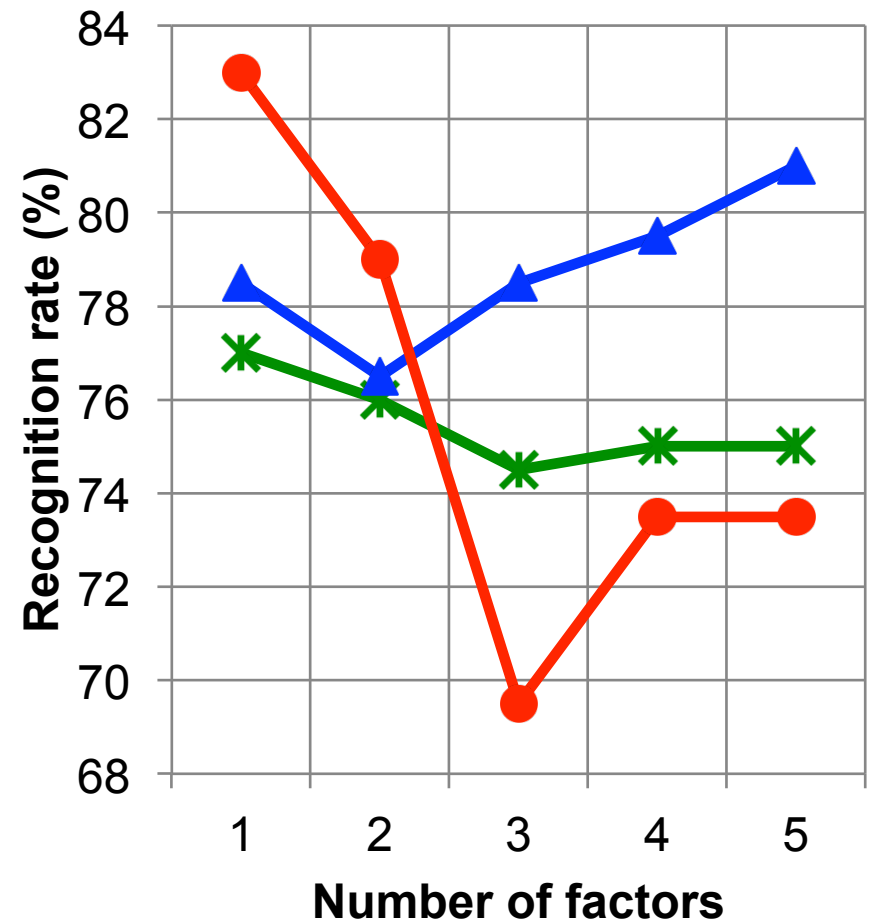


# RECOGNITION RATES (COMPARING PRIOR DIST.)

## HMEM-PPCA



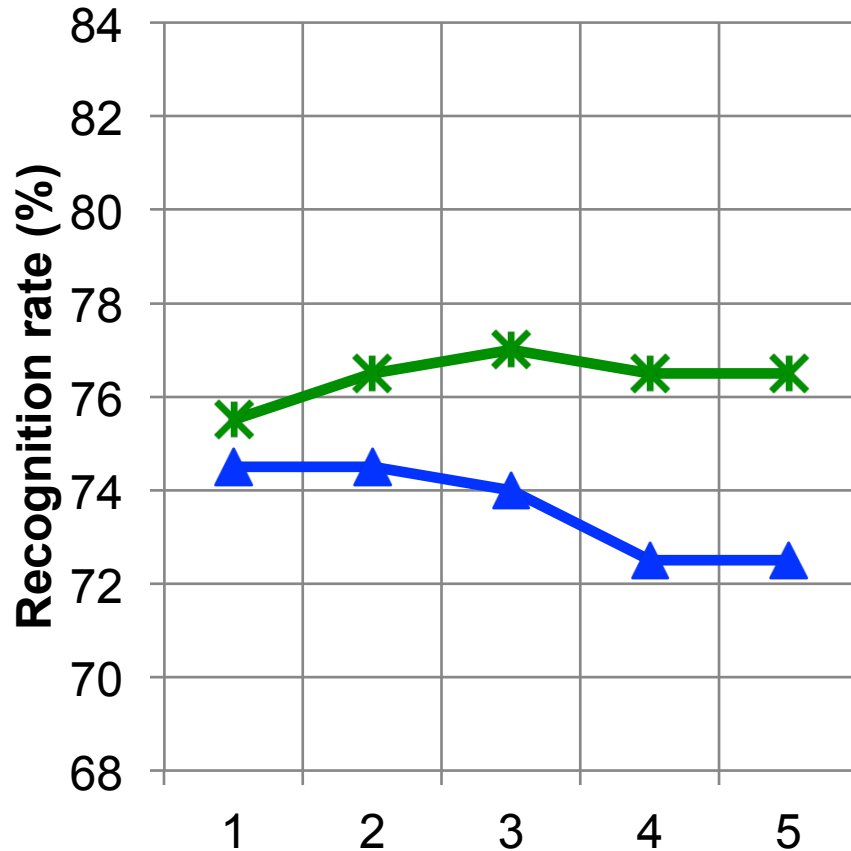
## HMEM-FA



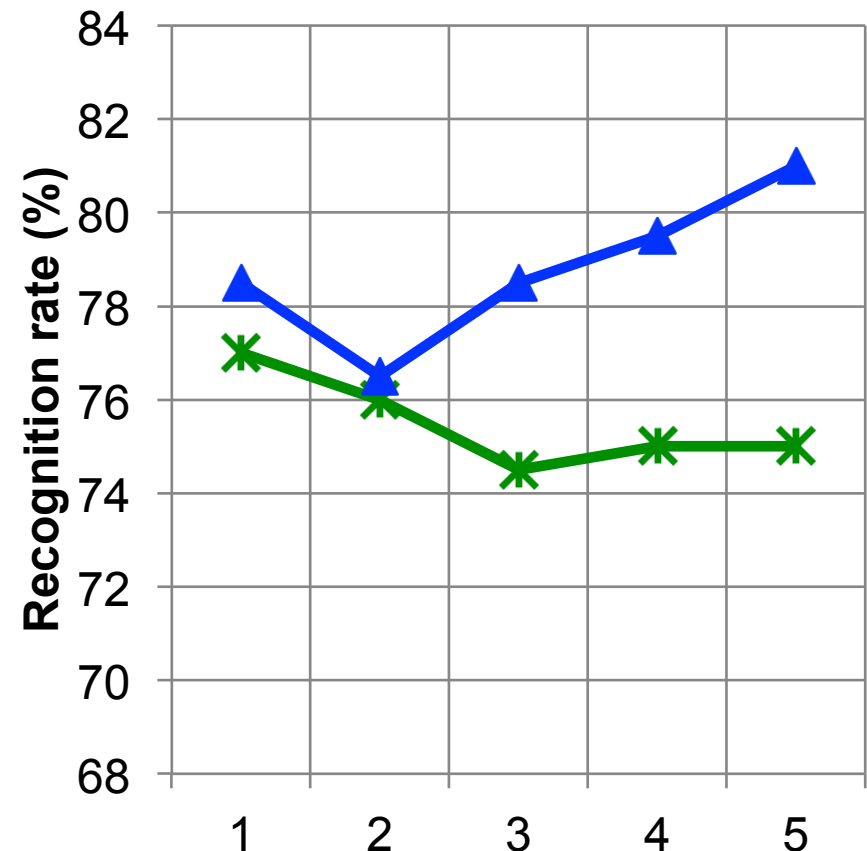
- \*— flat
- ▲— SLUBM
- UBM

# RECOGNITION RATES (COMPARING PRIOR DIST.)

## HMEM-PPCA



## HMEM-FA

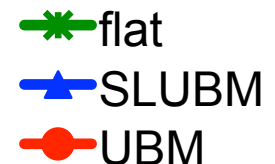


HMEM-PPCA : flat outperformed SLUBM

HMEM-FA : SLUBM outperformed flat

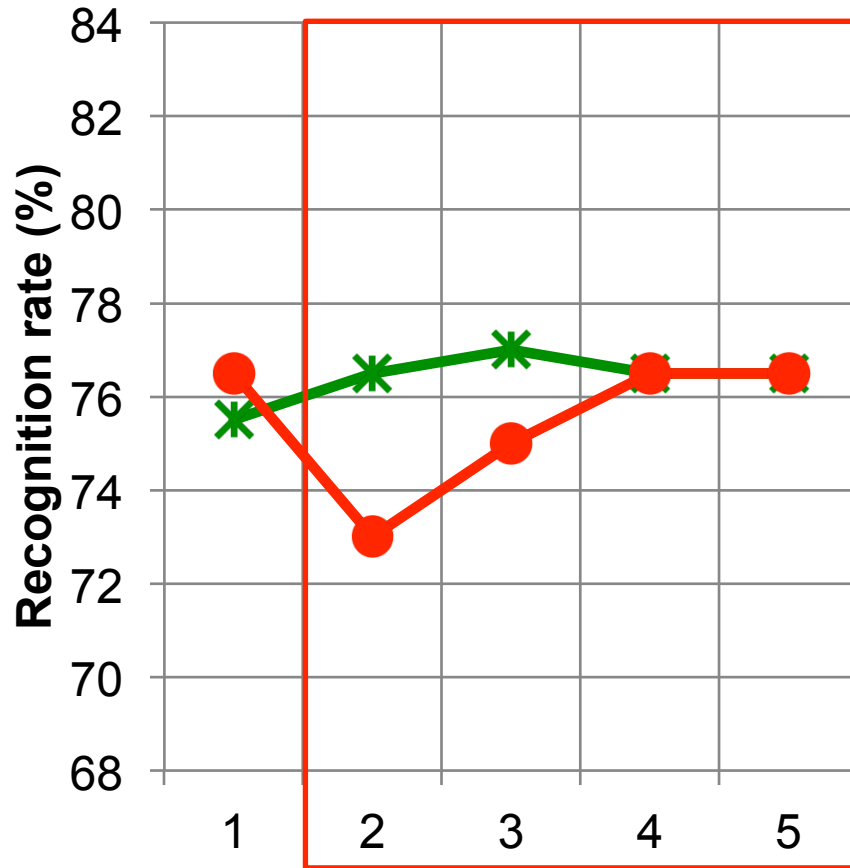
⇒ SLUBM is effective for FA (diagonal) structure

of factors

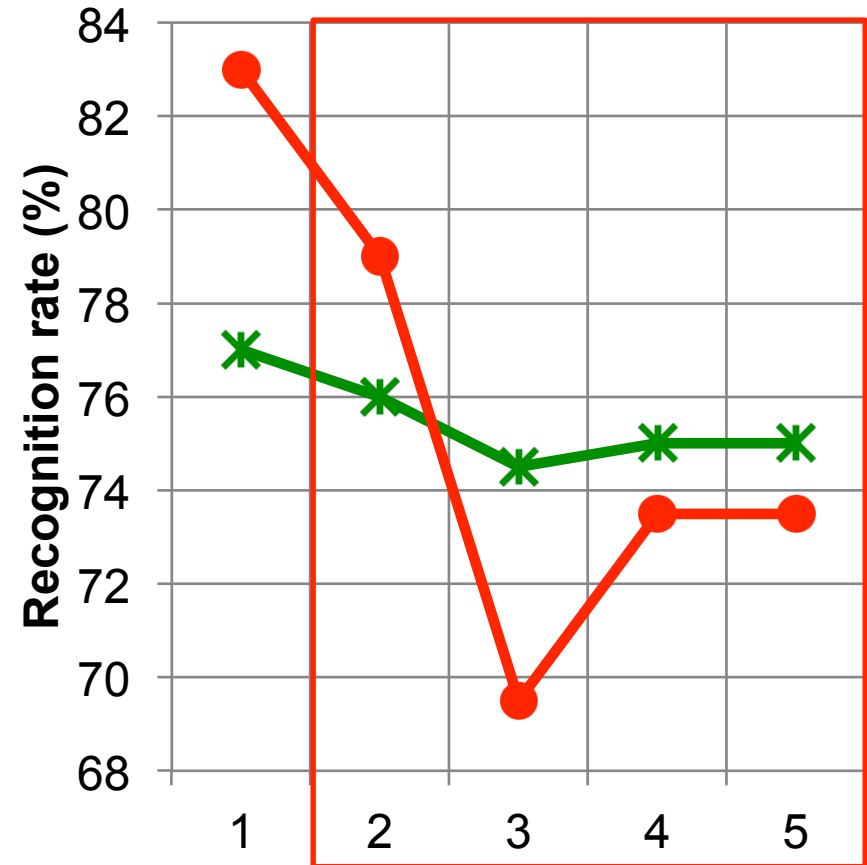


# RECOGNITION RATES (COMPARING PRIOR DIST.)

## HMEM-PPCA



## HMEM-FA



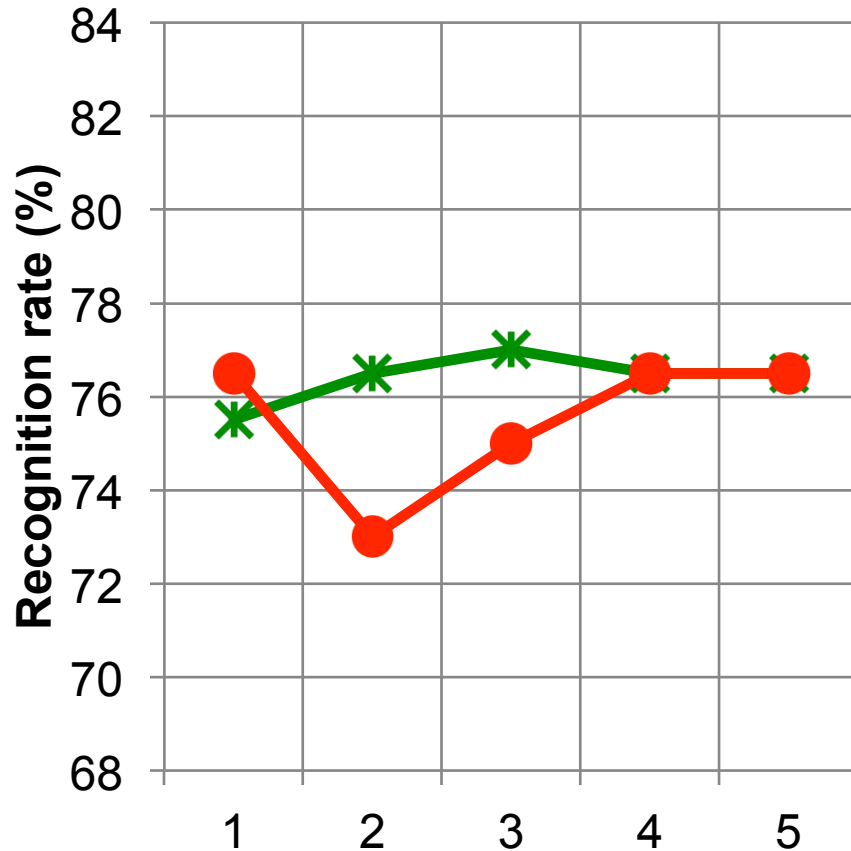
No significant difference between flat and UBM  
⇒ Prior dist. had tuned under the condition  
that the number of factor was one

Number of factors

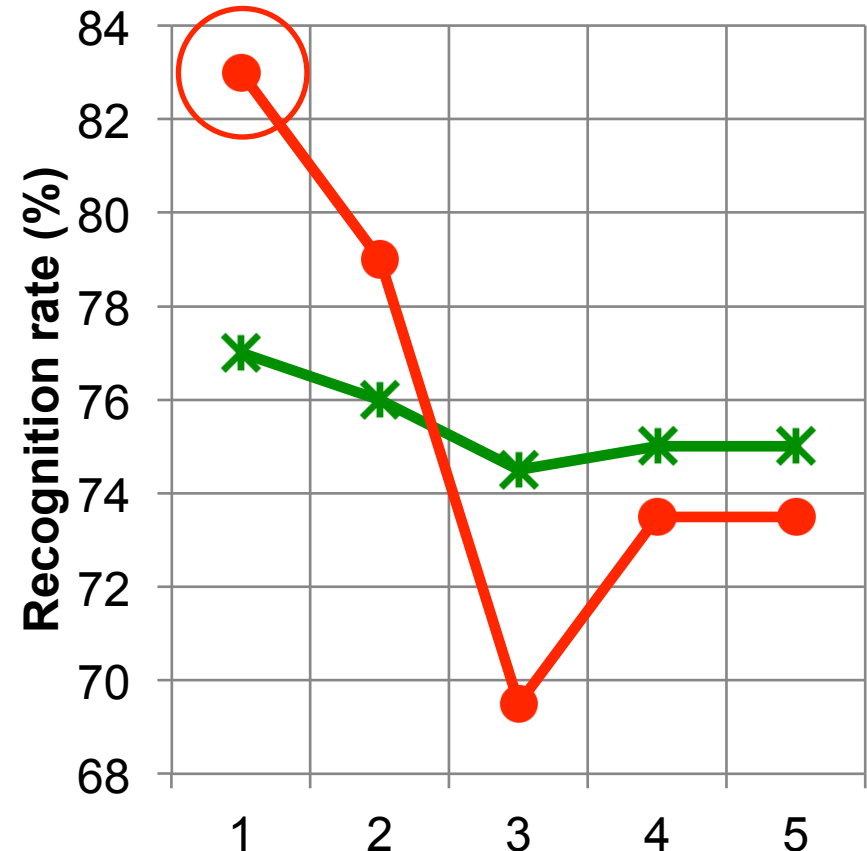
- flat
- SLUBM
- UBM

# RECOGNITION RATES (COMPARING PRIOR DIST.)

## HMEM-PPCA



## HMEM-FA



Number of factors

Significant high recognition rate

⇒ High recognition rate can be expected  
if prior dist. can be set adequately

—\*— flat  
—★— SLUBM  
—●— UBM

# CONCLUSION

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- Focus on technique for modeling geometric variations
- Apply Bayesian criterion to HMEMs
  - ◆ Derive VB method for HMEMs
  - ◆ Face recognition experiments
    - HMEMs based on VB method outperformed ML method
    - Recognition rate is improved by using an appropriate prior distribution
- Future work
  - ◆ Investigation of appropriate parameter sharing structures of HMEMs
  - ◆ Experiments on various image recognition tasks